

<b>Notice of References Cited</b>	Application/Control No. 10/672,560	Applicant(s)/Patent Under Reexamination HATFIELD, ERIC	
	Examiner Mark Eashoo, Ph.D.	Art Unit 1732	Page 1 of 1

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*	A	US-4,938,674	07-1990	Liberman et al.	425/72.1
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	M	US-			

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**NON-PATENT DOCUMENTS**

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